Applicant(s)/Patent Under Application/Control No. Reexamination 09/836,857 IWAMATSU, SEIICHI Notice of References Cited Art Unit Examiner Page 1 of 1 David A Vanore 2881 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-5,743,998 04-1998 Park, Sun Woo 216/51 Α US-В US-С D US-US-Ε US-F G US-US-Н US-US-

FOREIGN PATENT DOCUMENTS

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